


<b>Search Notes</b>  	<b>Application/Control No.</b>  10555729	<b>Applicant(s)/Patent Under Reexamination</b>  NIE ET AL.
	<b>Examiner</b>  Leon Y Lum	<b>Art Unit</b>  1641

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
Inventor search in eDAN, PALM and STN (search history attached)	10/17/08	LYL
EAST: class and keyword (search history attached)	10/17/08	LYL
STN: medline, embase, biosis, scisearch, caplus (search history attached)	10/17/08	LYL

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

/Leon Y Lum/  
Examiner,Art Unit 1641